

■ General Description

Voltage detectors (VDs) are used for short-circuit protection, but are deficient for dead shorts. This is because the output (VOUT) of a VD becomes unstable when the detection voltage at the VD's input voltage (VIN) pin decreases to below the VD's lowest operating voltage of 0.9 V. The short circuit protection circuits shown below halt IC operation in the event of a dead short at the output. These latch-type circuits are realized by adding few components as peripheral circuits to an IC.

■ Features

- Effective for dead short protection
- Makes possible strengthening of protection circuits by combining with the XC9201 series (with current-limiting capability).

■ Functional Description 1

● During Start-Up (Delayed Protection Circuits)

The capacitance of capacitor 1 (C1) is suitably selected to delay the time taken by VBE of transistor 1 (Q1) to reach approximately 0.6 V. This is aimed at preventing transistor 1 (Q1) from turning on and from setting CE = 0 V when CE_in becomes active. The output voltage reaches 2 V or more and transistor 2 (Q2) turns on during this delay. This operation establishes a short circuit across the base and emitter (B-E) of transistor 1 (Q1), thus allowing transistor 1 (Q1) to remain OFF.

The time taken by the C1 voltage to reach 0.6 V must be set to be longer than the IC's soft start time.

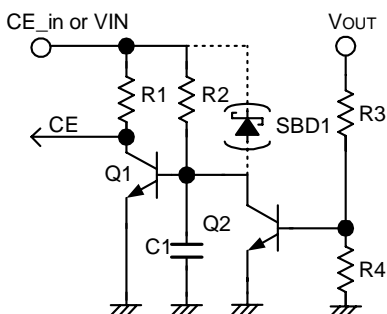
<<Formula for Time Delay>>

$$T = -R2 \times C1 \times \ln \left(\frac{CE_in - V_{BE1}}{CE_in} \right)$$

where,

- T : time delay of transistor Q1 (sec)
- R2 : resistance of resistor 2 (Ω)
- C1 : capacitance of capacitor C1 (F)
- VBE1 : VBE of transistor Q1 (V)
- CE_in: signal voltage (V)

■ Basic Circuit



* Add SBD1 to the circuit to discharge C1 instantaneously, if necessary.

Note

Bipolar transistors are current-driven devices. A certain amount of current must be passed through them to ensure proper operation.

■ Functional Description 2

● During Output Detection (Output Short-Circuited)

The voltage between resistor 4 and ground (R4-GND) decreases to below VBE of transistor 2 (Q2), which is approximately 0.6 V, when the output voltage (VOUT) is short-circuited. Transistor 2 (Q2) will then be turned off. A current flows into capacitor 1 (C1), which has been short-circuited by transistor 2 (Q2). The voltage between capacitor 1 and ground (C1-GND) increases gradually. When this voltage becomes equal to VBE of transistor 1 (Q1), which is approximately 0.6 V, transistor 1 (Q1) turns on, then CE, being short-circuited, decreases to 0 V, and the IC stops.

<<Calculation of Constants for Voltage Detection>>

Assume that $I_{c2} = 0.1 \text{ m (A)}$ and $CE_in = 5 \text{ (V)}$ as conditions in determining constants.

First,

$$R2 = \frac{CE_in}{I_{c2}} = \frac{5}{0.1 \text{ m}} = 50 \text{ k} \rightarrow \text{Hence, select } 51 \text{ k } (\Omega) \text{ for } R2.$$

The next step is to determine the current I_{B2} .

Assuming that $h_{fe} = 100$ for Q2,

$$I_{B2} = \frac{I_{c2}}{h_{fe}} = \frac{0.1 \text{ m}}{100} = 1 \mu \text{ (A)}$$

Assume that a bias current (I_{BIAS}) 10 times or more higher than the current flowing to the base is applied to R3 and R4.

$$R4 = \frac{V_{BE2}}{I_{BIAS}} = \frac{0.6}{12 \mu} = 50 \text{ k} \rightarrow \text{Hence, select } 51 \text{ k } (\Omega) \text{ for } R4.$$

Set the detection voltage V_{DF} to 2 (V), then,

$$V_{R4}(V_{BE2}) : V_{R3} = R4 : R3$$

$$R3 = \frac{V_{R3} \times R4}{V_{R4}(V_{BE2})} = \frac{1.4 \times 51 \text{ k}}{0.6} = 119 \text{ k}$$

→ Hence, 120 k (Ω) is selected for R3.

■ Application Example (Step-Down Circuit)

